TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC7MH273FK

#### Octal D-Type Flip Flop with Clear

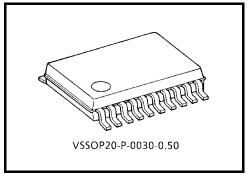
The TC7MH273FK is an advanced high speed CMOS octal D-type flip-flop fabricated with silicon gate  $\rm C^2MOS$  technology.

It achieves the high speed operation similar to equivalent bipolar schottky TTL while maintaining the CMOS low power dissipation.

Information signals applied to D inputs are transferred to the Q outputs on the positive going edge of the clock pulse.

When the  $\overline{\text{CLR}}$  input is held "L", the Q outputs are at a low logic level independent of the other inputs.

An input protection circuit ensures that 0 to 7 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

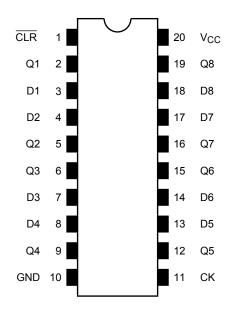


Weight: 0.03 g (typ.)

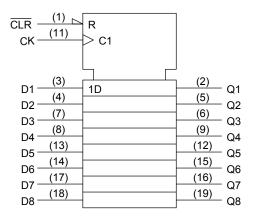
#### **Features**

- High speed:  $f_{max} = 165 \text{ MHz}$  (typ.) (V<sub>CC</sub> = 5 V)
- Low power dissipation:  $I_{CC} = 4 \mu A \text{ (max) (Ta} = 25 ^{\circ}\text{C)}$
- High noise immunity:  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays:  $t_{pLH} \approx t_{pHL}$
- Wide operating voltage range: VCC (opr) = 2~5.5 V
- Low noise:  $V_{OLP} = 0.8 \text{ V (max)}$
- Pin and function compatible with 74ALS273

### Pin Assignment (top view)



### **IEC Logic Symbol**

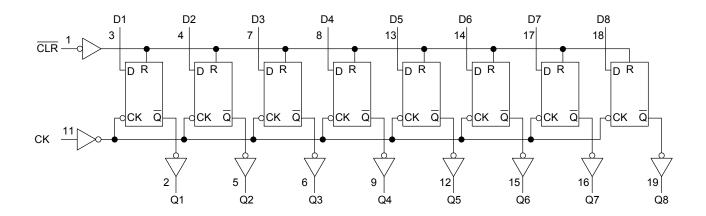


#### **Truth Table**

	Inputs		Outputs	- Function		
CLR	D	CK	Q	1 dilction		
L	Х	Х	L	Clear		
Н	L		L			
Н	Н		Н	_		
Н	Х	$\overline{}$	Qn	No change		

X: Don't care

### **System Diagram**



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# **Maximum Ratings**

Characteristics	Symbol	Rating	Unit
Supply voltage range	V <sub>CC</sub>	-0.5~7.0	V
DC input voltage	V <sub>IN</sub>	-0.5~7.0	V
DC output voltage	V <sub>OUT</sub>	-0.5~V <sub>CC</sub> + 0.5	V
Input diode current	I <sub>IK</sub>	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V <sub>CC</sub> /ground current	Icc	±75	mA
Power dissipation	PD	180	mW
Storage temperature	T <sub>stg</sub>	-65~150	°C

# **Recommended Operating Conditions**

Characteristics	Symbol	Rating	Unit
Supply voltage	voltage V <sub>CC</sub> 2.0~5.5		V
Input voltage	V <sub>IN</sub>	0~5.5	V
Output voltage	V <sub>OUT</sub>	0~V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>	-40~85	°C
Input rise and fall time	dt/dv	$0\sim100~(V_{CC}=3.3\pm0.3~V)$	ns/V
input nse and ian time	uuuv	$0\sim20 \ (V_{CC}=5\pm0.5 \ V)$	113/ V

### **Electrical Characteristics**

### **DC Characteristics**

Characteristics		Symbol Test Condition			Ta = 25°C Ta = -40~85°C				0~85°C	- Unit	
Criarac			V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	Offic		
					2.0	1.50	_	_	1.50		
Input voltage	"H" level	V <sub>IH</sub>	_		3.0~5.5	V <sub>CC</sub> × 0.7			V <sub>CC</sub> × 0.7	١	V
input voitage					2.0		_	0.50	_	0.50	V
	"L" level	V <sub>IL</sub>		_		l	_	V <sub>CC</sub> × 0.3	_	$\begin{array}{c} V_{CC} \\ \times  0.3 \end{array}$	
	"H" level		V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 μA	2.0	1.9	2.0	_	1.9		
					3.0	2.9	3.0	_	2.9		
					4.5	4.4	4.5	_	4.4		
				$I_{OH} = -4 \text{ mA}$	3.0	2.58	_	_	2.48		
Output				$I_{OH} = -8 \text{ mA}$	4.5	3.94	_	_	3.80		V
voltage			V <sub>IN</sub> = V <sub>IH</sub>		2.0		0	0.1	_	0.1	V
				$I_{OL} = 50 \mu A$	3.0		0	0.1	—	0.1	
	"L" level				4.5		0	0.1	—	0.1	
				I <sub>OL</sub> = 4 mA	3.0		_	0.36	—	0.44	
				I <sub>OL</sub> = 8 mA	4.5		_	0.36	_	0.44	
Input leakage	Input leakage current $I_{IN}$ $V_{IN} = 5.5 \text{ V or GND}$		0~5.5	_	_	±0.1	_	±1.0	μΑ		
Quiescent sup	ply current	I <sub>CC</sub>	$V_{IN} = V_{CC}$	or GND	5.5		_	4.0	_	40.0	μΑ

# Timing Requirements (Input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	vmbol Test Condition		Ta = 25°C		Ta = -40~85°C	Unit
Characteristics	Symbol	rest Condition	V <sub>CC</sub> (V)	Тур.	Limit	Limit	Offic
Minimum pulse width	t <sub>w (L)</sub>		$3.3 \pm 0.3$	_	5.5	6.5	ne
(CK)	t <sub>w (H)</sub>		$5.0 \pm 0.5$	_	5.0	5.0	ns
Minimum pulse width	•		$3.3 \pm 0.3$	_	5.0	6.0	ns
(CLR)	t <sub>w (L)</sub>		$5.0 \pm 0.5$		5.0	5.0	115
Minimum set-up time	ts	_	$3.3 \pm 0.3$	_	5.5	6.5	ns
			$5.0 \pm 0.5$		4.5	4.5	10
Minimum hold time	t <sub>h</sub>		$3.3 \pm 0.3$		1.0	1.0	ns
wiinimum noid time		_	$5.0 \pm 0.5$		1.0	1.0	110
Minimum removal time	<b>t</b>		$3.3 \pm 0.3$		2.5	2.5	ns
(CLR)	t <sub>rem</sub>		$5.0 \pm 0.5$		2.0	2.0	110

#### AC Characteristics (Input: $t_r = t_f = 3$ ns)

Characteristics	Characteristics Symbol Test Conditio				Ta = 25°C			Ta = -4	Unit	
Characteristics			V <sub>CC</sub> (V)	C <sub>L</sub> (pF)	Min	Тур.	Max	Min	Max	Offic
			3.3 ± 0.3	15		8.7	13.6	1.0	16.0	ns
Propagation delay time	t <sub>pLH</sub>			50		11.2	17.1	1.0	19.5	
(CK-Q)	t <sub>pHL</sub>	_	5.0 ± 0.5	15		5.8	9.0	1.0	10.5	113
			3.0 ± 0.3	50		7.3	11.0	1.0	12.5	
			3.3 ± 0.3	15		8.9	13.6	1.0	16.0	
Propagation delay time	t <sub>pHL</sub>		3.3 ± 0.3	50		11.4	17.1	1.0	19.5	ns
(CLR -Q)		_	5.0 ± 0.5	15		5.2	8.5	1.0	10.0	115
				50		6.7	10.5	1.0	12.0	
	f <sub>max</sub>	_	3.3 ± 0.3	15	75	120		65	_	- MHz
Maximum clock frequency				50	50	75	_	45	_	
Maximum clock frequency			5.0 ± 0.5	15	120	165		100	_	
				50	80	110	_	70	_	
Output to output skew	t <sub>osLH</sub>	(Note1)	$3.3 \pm 0.3$	50	_	_	1.5	_	1.5	ns
Output to output skew	t <sub>osHL</sub>	(Note I)	5.0 ± 0.5	50		_	1.0	_	1.0	115
Input capacitance	C <sub>IN</sub>	-	_			4	10	_	10	pF
Power dissipation capacitance	C <sub>PD</sub>			(Note2)	_	31	_	_	_	pF

Note1: This parameter is guaranteed by design.

 $t_{OSLH} = |t_{pLHm} - t_{pLHn}|, t_{OSHL} = |t_{pHLm} - t_{pHLn}|$ 

Note2: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 (per F/F)$ 

And the total C<sub>PD</sub> when n pcs of flip-flop operate can be gained by the following equation:

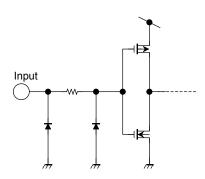
 $C_{PD}$  (total) = 22 + 9 · n

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# Noise Characteristics (Input: $t_r = t_f = 3 \text{ ns}$ )

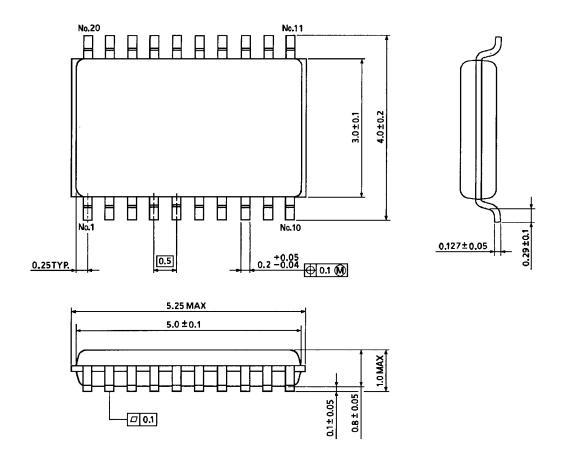
Characteristics	Symbol	Test Condition		Ta = 25°C		Unit
Characteristics	Syllibol	rest condition	V <sub>CC</sub> (V)	Тур.	Limit	Offic
Quiet output maximum dynamic V <sub>OL</sub>	V <sub>OLP</sub>	C <sub>L</sub> = 50 pF	5.0	0.5	0.8	V
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	C <sub>L</sub> = 50 pF	5.0	-0.5	-0.8	V
Minimum high level dynamic input voltage $V_{\text{IH}}$	V <sub>IHD</sub>	C <sub>L</sub> = 50 pF	5.0	_	3.5	V
Maximum low level dynamic input voltage $V_{\text{IL}}$	V <sub>ILD</sub>	C <sub>L</sub> = 50 pF	5.0	_	1.5	V

# **Input Equivalent Circuit**



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### **Package Dimensions**



Weight: 0.03 g (typ.)

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